Power MOSFET and Schottky Diode

30 V, N-Channel with 0.5 A Schottky Barrier Diode, 1.6 x 1.6 x 0.55 mm µCool™ Package

Features

- Low Qg and Capacitance to Minimize Switching Losses
- Low Profile UDFN 1.6x1.6 mm for Board Space Saving
- Low VF Schottky Diode
- ESD Protected Gate
- This is a Halide-Free Device
- This is a Pb-Free Device

Applications

- DC-DC Boost Converter
- Color Display and Camera Flash Regulators
- Optimized for Power Management Applications for Portable Products, such as Cell Phones, PMP, DSC, GPS, and others

MAXIMUM RATINGS (T_{.I} = 25°C unless otherwise stated)

Parameter			Symbol	Value	Units
Drain-to-Source Voltage			V _{DSS}	30	V
Gate-to-Source Volt	age		V _{GS}	±8.0	V
Continuous Drain	Steady State	T _A = 25°C	I _D	1.5	Α
Current (Note 1)	State	T _A = 85°C		1.1	
	t ≤ 5 s	T _A = 25°C		1.9	
Power Dissipation (Note 1)	Steady State	T _A = 25°C	P _D	0.8	W
	t ≤ 5 s	T _A = 25°C		1.3	
Continuous Drain	Steady	T _A = 25°C	I _D	1.2	Α
Current (Note 2)	State	T _A = 85°C		0.9	
Power Dissipation (Note 2) T _A = 25°C		P _D	0.5	W	
Pulsed Drain Current tp = 10 μs			I _{DM}	8.0	Α
MOSFET Operating Junction and Storage Temperature			T _J , T _{STG}	-55 to 150	°C
Schottky Operating Junction & Storage Temperature			T _J , T _{STG}	-55 to 125	°C
Source Current (Body Diode) (Note 2)			Is	1.5	Α
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C
Gate-to-Source ESI (HBM) per JESD22-			ESD	1000	V

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

- Surface Mounted on FR4 Board using 1 in sq pad size (Cu area = 1.127 in sq [2 oz] including traces).
- Surface-mounted on FR4 board using the minimum recommended pad size of 30 mm², 2 oz. Cu.



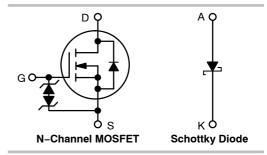
ON Semiconductor®

http://onsemi.com

MOSFET					
V _{(BR)DSS}	R _{DS(on)} MAX	I _D MAX			
	200 mΩ @ 4.5 V	1.5 A			
30 V	250 mΩ @ 3.0 V	0.5 A			
	350 mΩ @ 2.5 V	0.5 A			

SCHOTTKY DIODE

V _R MAX	V _F TYP	I _F MAX
30 V	0.52 V	0.5 A



MARKING DIAGRAM



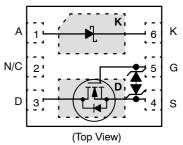
UDFN6 CASE 517AT μCOOL™



AA = Specific Device Code M = Date Code

■ = Pb-Free Package

PIN CONNECTIONS



ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 2 of this data sheet.

DEVICE ORDERING INFORMATION

Device	Package	Shipping [†]
NTLUF4189NZTAG	UDFN6 (Pb-Free)	3000 / Tape & Reel
NTLUF4189NZTBG	UDFN6 (Pb-Free)	3000 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

Schottky Diode Maximum Ratings (T_J = 25°C unless otherwise stated)

Parameter	Symbol	Value	Units
	,		0.110
Peak Repetitive Reverse Voltage	V_{RRM}	30	V
DC Blocking Voltage	V_{R}	30	>
Average Rectified Forward Current	I _F	0.5	Α

Thermal Resistance Ratings

Parameter	Symbol	Max	Units
Junction-to-Ambient – Steady State (Note 3)	$R_{\theta JA}$	155	°C/W
Junction-to-Ambient – t ≤ 5 s (Note 3)	$R_{\theta JA}$	100	
Junction-to-Ambient – Steady State min Pad (Note 4)	$R_{\theta JA}$	245	

MOSFET Electrical Characteristics (T_J = 25°C unless otherwise specified)

Parameter	Symbol	Test Co	ondition	Min	Тур	Max	Units
OFF CHARACTERISTICS				-			
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J	I _D = 250 μA, ref to 25°C			22		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V,	T _J = 25°C			1.0	μΑ
		$V_{DS} = 24 \text{ V}$	T _J = 85°C			10	
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V	_{GS} = ± 8.0 V			10	μΑ
ON CHARACTERISTICS (Note 5)					•		
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}$	I _D = 250 μA	0.4	1.1	1.5	V
Negative Threshold Temp. Coefficient	V _{GS(TH)} /T _J				3.0		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 4.5 V, I _D = 1.5 A			145	200	mΩ
		V _{GS} = 3.0 V, I _D = 0.5 A		185	250		
		V _{GS} = 2.5 \	V, I _D = 0.5 A		220	350	
Forward Transconductance	9FS	V _{DS} = 4.0 V, I _D = 0.15 A			1.1		S
CHARGES & CAPACITANCES					•		•
Input Capacitance	C _{ISS}				95		pF
Output Capacitance	Coss	$V_{GS} = 0 \text{ V, f} = 1 \text{ MHz,}$ $V_{DS} = 15 \text{ V}$			15		
Reverse Transfer Capacitance	C _{RSS}				10		
Total Gate Charge	Q _{G(TOT)}				1.4	3.0	nC
Threshold Gate Charge	Q _{G(TH)}	V _{GS} = 4.5 V.	V _{DS} = 15 V;		0.2		
Gate-to-Source Charge	Q_GS	I _D =	1.5 A		0.4		
Gate-to-Drain Charge	Q_{GD}				0.4		

- 3. Surface-mounted on FR4 board using 1 in sq pad size (Cu area = 1.127 in sq [2 oz] including traces)
- 4. Surface-mounted on FR4 board using the minimum recommended pad size of 30 mm², 2 oz. Cu.
- 5. Pulse Test: pulse width \leq 300 μ s, duty cycle \leq 2%
- 6. Switching characteristics are independent of operating junction temperatures

Parameter	Symbol	Test Co	ondition	Min	Тур	Max	Units	
SWITCHING CHARACTERISTICS, VG	,							
Turn-On Delay Time	t _{d(ON)}				7.0		ns	
Rise Time	t _r	.,			4.5			
Turn-Off Delay Time	t _{d(OFF)}	$V_{GS} = 4.5 \text{ V},$ $I_{D} = 1A,$	$V_{DD} = 15 \text{ V},$ $R_G = 6 \Omega$		10.2			
Fall Time	t _f				1.2			
DRAIN-SOURCE DIODE CHARACTE	·							
Forward Diode Voltage	V_{SD}	V 0V	T _J = 25°C		0.8	1.2	V	
·		$V_{GS} = 0 V$, $I_S = 1A$	T _{.1} = 85°C		0.75			
Reverse Recovery Time	t _{RR}		1 3		10.5		ns	
Charge Time	t _a	\/ 0\/ dl	- /dt 100 A /::0		8.9			
Discharge Time	t _b	V _{GS} = 0 V, dist I _S =	ე/dt = 100 A/μs, ⊧ 1 A		1.6			
Reverse Recovery Charge	Q _{RR}	1			2.1		nC	
SCHOTTKY DIODE ELECTRICAL CH		(T _J = 25°C unless ot	therwise specified)			<u> </u>		
Parameter	Symbol	Test Co	ondition	Min	Тур	Max	Units	
Maximum Instantaneous Forward Voltage	V _F	I _F = 10 mA		0.27	0.37	V		
		I _F = 1	I _F = 100 mA		0.36		0.46	
	I _F = 500 mA			0.52	0.62			
Maximum Instantaneous	I _R	V _R =	10 V		2.0	10	μА	
Reverse Current		V _R = 30 V			20	200		
SCHOTTKY DIODE ELECTRICAL CH	ARACTERISTICS	(T _J = 85°C unless ot	therwise specified)	1		I		
Maximum Instantaneous	V _F	$I_F = 10 \text{ mA}$ $I_F = 100 \text{ mA}$ $I_F = 500 \text{ mA}$			0.2		V	
Forward Voltage					0.3			
					0.51			
Maximum Instantaneous	I _R	V _R =	: 10 V		80		μА	
Reverse Current		V _B = 30 V			525			
SCHOTTKY DIODE ELECTRICAL CH	ARACTERISTICS	(T _J = 125°C unless o	otherwise specified)	1		I		
Maximum Instantaneous	V _F	I _F = 1	I _F = 10 mA		0.14		V	
Forward Voltage		I _F = 100 mA			0.27			
		I _F = 5	00 mA		0.51			
				1	000		μΑ	
Maximum Instantaneous	I _R	V _R =	: 10 V		600		μΑ	
Maximum Instantaneous Reverse Current	I _R		: 10 V : 30 V		3000		μΑ	

- 3. Surface-mounted on FR4 board using 1 in sq pad size (Cu area = 1.127 in sq [2 oz] including traces) 4. Surface-mounted on FR4 board using the minimum recommended pad size of 30 mm², 2 oz. Cu. 5. Pulse Test: pulse width \leq 300 μ s, duty cycle \leq 2% 6. Switching characteristics are independent of operating junction temperatures

С

Capacitance

 $V_R = 5 V$, f = 1.0 MHz

6.0

рF

TYPICAL MOSFET CHARACTERISTICS

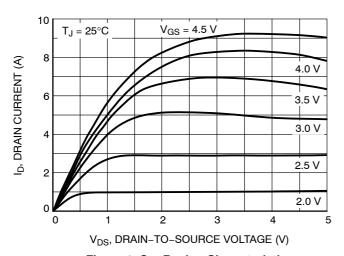


Figure 1. On-Region Characteristics

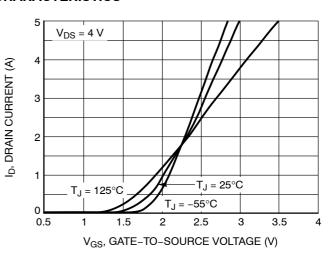


Figure 2. Transfer Characteristics

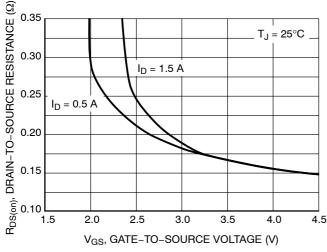


Figure 3. On-Resistance vs. Gate Voltage

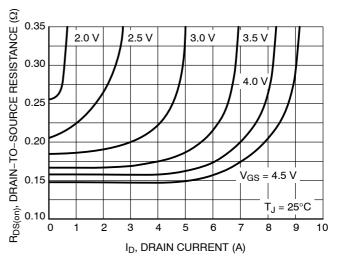


Figure 4. On-Resistance vs. Drain Current and Gate Voltage

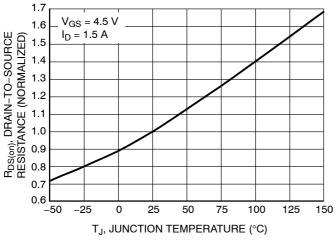


Figure 5. On–Resistance Variation with Temperature

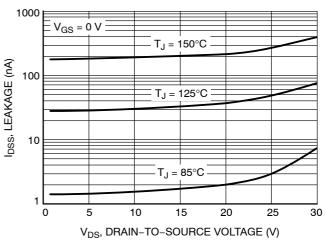


Figure 6. Drain-to-Source Leakage Current vs. Voltage

TYPICAL MOSFET CHARACTERISTICS

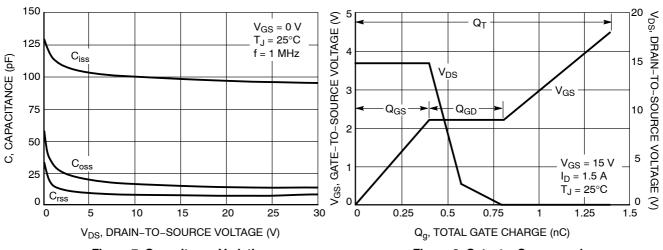
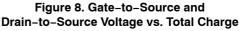


Figure 7. Capacitance Variation



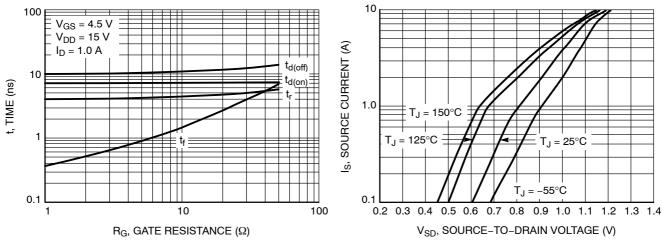


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

Figure 10. Diode Forward Voltage vs. Current

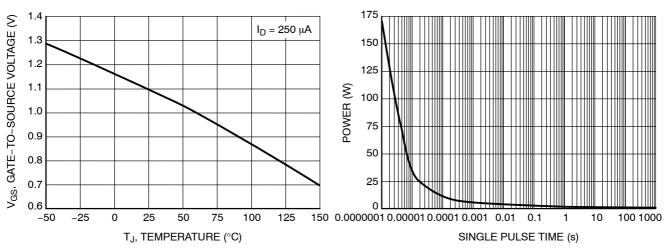


Figure 11. Threshold Voltage

Figure 12. Single Pulse Maximum Power Dissipation

TYPICAL MOSFET CHARACTERISTICS

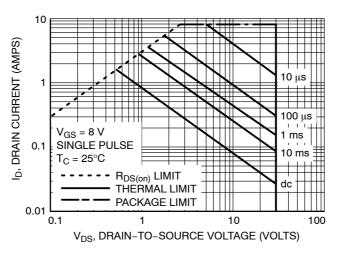


Figure 13. Maximum Rated Forward Biased Safe Operating Area

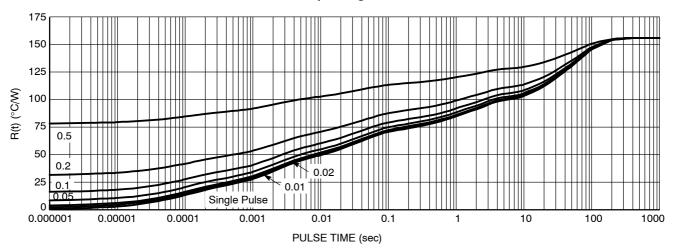


Figure 14. FET Thermal Response

TYPICAL SCHOTTKY CHARACTERISTICS

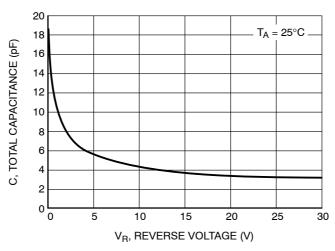
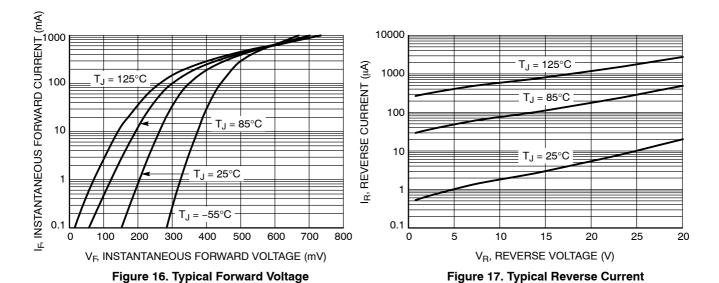


Figure 15. Total Capacitance







UDFN6 1.6x1.6, 0.5P CASE 517AT **ISSUE O**

DATE 02 SEP 2008

NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994. CONTROLLING DIMENSION: MILLIMETERS.
- DIMENSION b APPLIES TO PLATED TERMINAL AND IS MEASURED BETWEEN 0.15 AND 0.30 mm FROM TERMINAL.
 COPLANARITY APPLIES TO THE EXPOSED
- PAD AS WELL AS THE TERMINALS.

	MILLIMETERS				
DIM	MIN MAX				
Α	0.45	0.55			
A 1	0.00	0.05			
А3	0.13	REF			
b	0.20	0.30			
D	1.60	BSC			
Е	1.60 BSC				
e	0.50 BSC				
D1	1.14	1.34			
D2	0.38	0.58			
E1	0.54	0.74			
K	0.20				
L	0.15	0.35			
L1		0.10			

GENERIC MARKING DIAGRAM*



XX = Specific Device Code

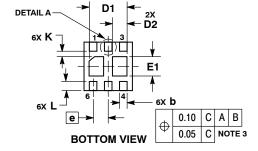
M = Date Code

= Pb-Free Package

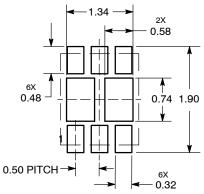
(Note: Microdot may be in either location)

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "■", may or may not be present. Some products may not follow the Generic Marking.

·D В 0.10 C **DETAIL A** PIN ONE REFERENCE OPTIONAL CONSTRUCTION 0.10 C MOLD CMPD EXPOSED Cu-**TOP VIEW** АЗ (A3) **DETAIL B** 0.05 С **A1 DETAIL B** OPTIONAL 0.05 C CONSTRUCTION **SIDE VIEW** C SEATING



SOLDERMASK DEFINED MOUNTING FOOTPRINT*



DIMENSIONS: MILLIMETERS

*For additional information on our Pb-Free strategy and soldering details, please download the onsemi Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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DESCRIPTION:	UDFN6, 1.6X1.6, 0.5P		PAGE 1 OF 1	

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